# 2SB0951 (2SB951), 2SB0951A (2SB951A)

Silicon PNP epitaxial planar type darlington

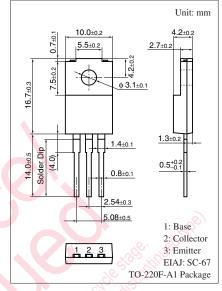
#### For midium-speed switching Complementary to 2SD1277 and 2SD1277A

#### Features

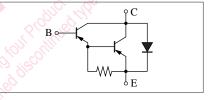
- $\bullet$  High forward current transfer ratio  $h_{FE}$
- High-speed switching
- Full-pack package which can be installed to the heat sink with one screw

#### Absolute Maximum Ratings $T_C = 25^{\circ}C$

Parameter	Symbol	Rating	Unit	
Collector-base voltage	2SB0951	V <sub>CBO</sub>	-60	V
(Emitter open)	2SB0951A		-80	
Collector-emitter voltage	2SB0951	V <sub>CEO</sub>	-60	V
(Base open)	2SB0951A		-80	
Emitter-base voltage (Coll	V <sub>EBO</sub>	-7	V	
Collector current	I <sub>C</sub>	-8	A	
Peak collector current	I <sub>CP</sub>	-12	Α	
Collector power		P <sub>C</sub>	45	W
dissipation	$T_a = 25^{\circ}C$		2	
Junction temperature		Tj	150	°C
Storage temperature		T <sub>stg</sub>	-55 to +150	°C



#### Internal Connection



### Electrical Characteristics $T_C = 25^{\circ}C \pm 3^{\circ}C$

Parameter		Symbol	Conditions	Min	Тур	Max	Unit
Collector-emitter voltage	2SB0951	V <sub>CEO</sub>	$I_{\rm C} = -30$ mA, $I_{\rm B} = 0$	-60			V
(Base open)	2SB0951A		differ solo.	-80			
Collector-base cutoff	2SB0951	I <sub>CBO</sub>	$V_{CB} = -60 \text{ V}, I_E = 0$			-100	μΑ
current (Emitter open)	2SB0951A		$V_{CB} = -80 \text{ V}, I_E = 0$			-100	
Emitter-base cutoff current (Collector open)		I <sub>EBO</sub>	$V_{EB} = -7 \text{ V}, I_C = 0$			-2	mA
Forward current transfer ratio		h <sub>FE1</sub> *	$V_{CE} = -3 V, I_C = -4 A$	1 0 0 0		10 000	
	- Ci	h <sub>FE2</sub>	$V_{CE} = -3 V, I_C = -8 A$	500			
Collector-emitter saturation voltage		V <sub>CE(sat)</sub>	$I_{C} = -4 A, I_{B} = -8 mA$			-1.5	V
Base-emitter saturation volt	age	V <sub>BE(sat)</sub>	$I_{C} = -4 A, I_{B} = -8 mA$			-2.0	V
Transition frequency	Big	$f_{T}$	$V_{CE} = -10 \text{ V}, I_C = -1 \text{ A}, f = 1 \text{ MHz}$		20		MHz
Turn-on time		t <sub>on</sub>	$I_{C} = -4 \text{ A}, I_{B1} = -8 \text{ mA}, I_{B2} = 8 \text{ mA}$		0.5		μs
Storage time		t <sub>stg</sub>	$V_{CC} = -50 \text{ V}$		2.0		μs
Fall time		t <sub>f</sub>			1.0		μs

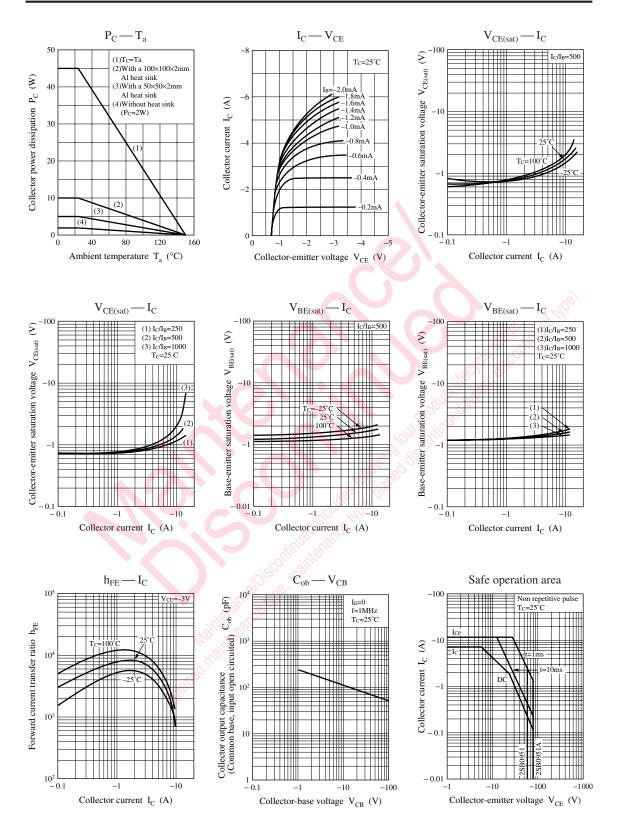
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

2. \*: Rank classification

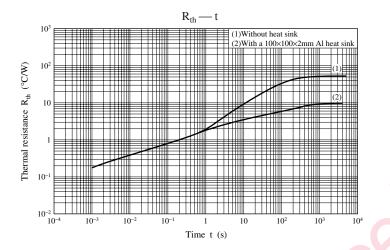
Rank	R	Q	Р
h <sub>FE1</sub>	1000 to 2500	2000 to 5000	4000 to 10000

Note) The part numbers in the parenthesis show conventional part number.

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